Rev: 000

ISSUE NO: 07020597



DATE OF ISSUE: 2008. 05. 22

SPECIFICATION

MODEL: SLHNNWH531N0S0QRC5

[Rank: (S0), (Q0, R0), (F2, G2, H2)]

HIGH POWER LED - SUNNIX

CUSTOMER: CML

SAMSUNG ELECTRO-MECHANICS									
DRAWN	DRAWN CHECKED APPROVED								

	SAMSUNG ELEC	TRO-MECHANIC	S
DRAWN	CHCKED(Sales)	CHECKED(Quality)	APPROVED
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SAMSUNG ELECTRO-MECHANICS CO,.LTD. 314, MAETAN3-DONG, YEONGTONG-GU, SUWON, GYUNGGI-DO, KOREA,442-743



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Product Outline

- 1) Feature
 - 1. Plastic Molded L/Frame type (7.0mm * 7.0mm * t 2.0mm)
 - 2. Beam Angle ($\triangle\theta$: 120 $^{\circ}$)
 - 3. High Power/Brightness Chip & Long Time Reliability
- 2) Applications
 - -. Automotive, Illumination etc.

■ Absolute Maximum Rating^{1),2)}

- -. Operation Forward Current 700 mA
- -. Peak Pulsed Forward Current 800 mA (Duty 1/10 Pulse Width 10msec)
- -. Reverse Voltage 5V
- -. Thermal Resistance(Rth) $\stackrel{\bf 3)}{=}$ 8 $^{\circ}$ C/W
- -. LED Junction Temperature (Tj) 125°C
- -. Operating Temperature Range (T_{opr}) -35 $^{\circ}$ $^{\circ}$ 85 $^{\circ}$
- -. Storage Temperature Range (T_{stg}) -40 $^{\circ}$ C $^{\sim}$ 110 $^{\circ}$ C

■ Characteristics^{1),2)}

Electrical Characteristcs

(Tj : 25°C)

Item	Rank	Symbol	Min.	Тур.	Max.	Unit	Conditions
Forward Voltage	S0	VF	3.2	-	4.5	V	IF=700mA
Reverse Voltage	-	VR	0.5	-	2.0	V	IR=10 ^{mA}

Chromaticity Coordinate

Ra	nk	CCx		ССу			CCT [K]	Condition			
0.0	Q0	0.3128	0.3250	0.3200	0.3011	0.2864	0.2981	0.3600	0.3407	6,000~7,000	I
QR	R0	0.3250	0.3428	0.3471	0.3200	0.2981	0.3138	0.3818	0.3600	5,000~6,000	IF=700mA

Luminous Flux

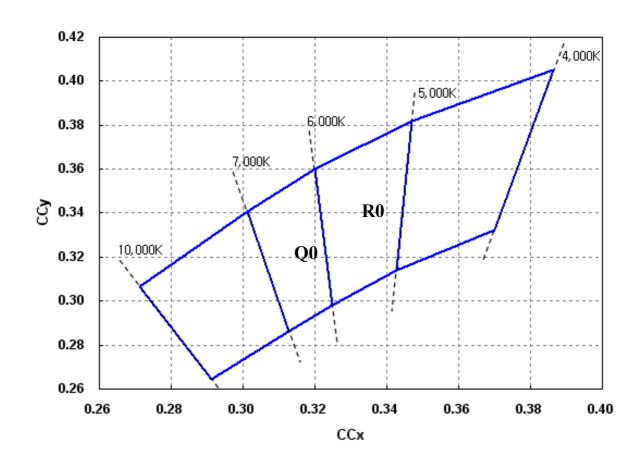
Rank		Symbol	Min.	Max.	Unit	Conditions	
	F2	G2 Φv	100	120			
C5	G2		Φv 120 140 Im		lm	IF=700 ^{mA}	
	H2		140	160			

Remarks)

- 1) Tolerance: V_F : \pm 0.1V, Φv : \pm 10%, CCx CCy: \pm 0.02
- 2) These specifications can be modified without any notices.
- 3) Proper thermal managements should be considered into a circuit design



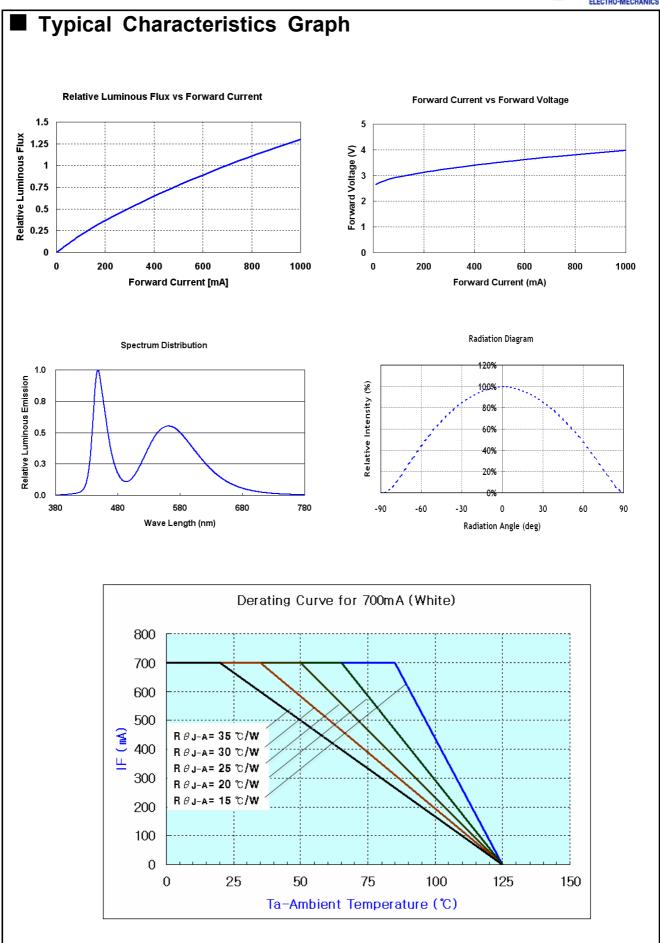
■ Chromaticity Diagram



* Approved Rank

V_{F}	CIE	lm
S0	Q0, R0	F2, G2, H2



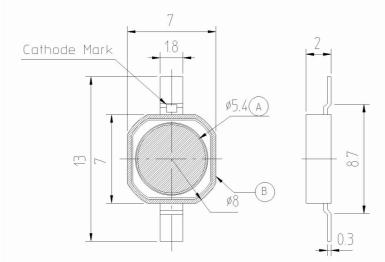


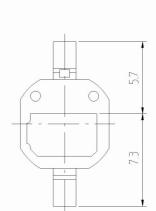


■ Outline Drawing and Dimension

Unit:mm

Tolerance: ±0.1



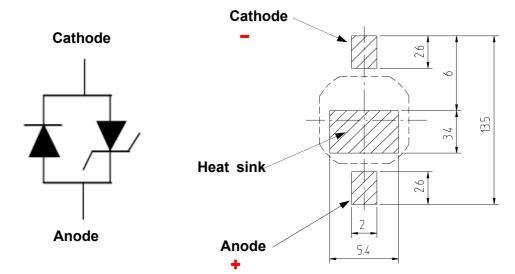


Pick and Place

- 1. Do not place pressure on the encapsulating resin ("A").
 - It is recommended to use a pick & place nozzle with inside diameter of 5.8mm.
- 2. The maximum compressing force is 15N on the polymer("B").

Circuit

Solder Pattern for Surface Mount

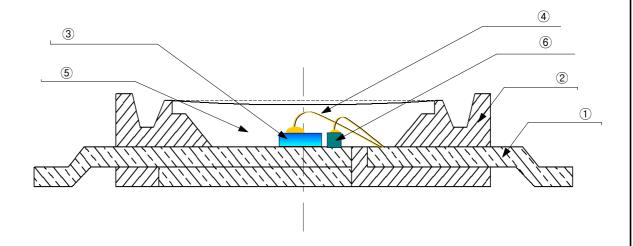


Remarks)

Make sure the heat sink is electrically connected to the Anode. Heat sink is to be soldered, If not, use the heat conductive adhesive



■ Package Structure



No	Item	Material	
1)	FRAME	Copper Frame(Silver plated)	
2	PACKAGE	Heat-resistant Polymer	
3	LED CHIP	SiC	
4	WIRE	Gold Wire	
(5)	RESIN	Silicone Resin	
6	ZENER DIODE	Si	



■ Reliability Test Items and Conditions

1) Test Items

Test Item	Test Conditions	Test Hours/Cycles	Sample No
Room Temperature life test	25°C, If=Max DC¹)	1,000 h	22
High Temperature humidity life test	85 ℃, 85 % RH, If=Max DC ¹⁾	1,000 h	22
High Temperature life test	85 ℃, If=Max DC ¹⁾	1,000 h	22
Low Temperature life test	-40℃, If=Max DC¹)	1,000 h	22
High Temperature Storage	110℃	1,000 h	11
Low Temperature Storage	-40℃	1,000 h	11
Thermal Shock	-40 / 120°C, each 30 min	200 cycles	22
Temperature humidity Cycle On/Off test	-40 / 85 $^{\circ}\mathrm{C}$, each 20 min, 100 min transfer Power On/off each 5 min, DC 350 $^{\mathrm{mA}}$	100 cycles	22
Reflow (Pb-Free)	Peak 260±5℃ for 10sec	3 times	11
ESD(HBM)	R_1 R_2 R_2 R_3 R_4 R_5	3 times (± 5 ^{kV})	5

1) Max. DC current depending on maximum current derating curve.

2) Criteria for Judging the Damage

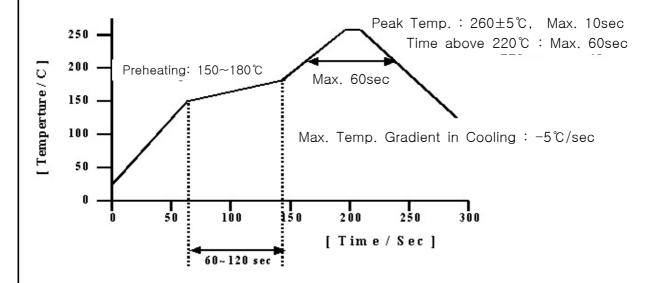
Item	Symbol	Toot Condition	Limit		
	Symbol	Test Condition	Min	Max	
Forward Voltage	VF	IF = 700 mA	-	U.S.L.*1.2	
Luminous Flux	Ф٧	IF = 700 mA	L.S.L.*0.5	-	

* USL: Upper Standard Level LSL: Lower Standard Level



Solder Conditions

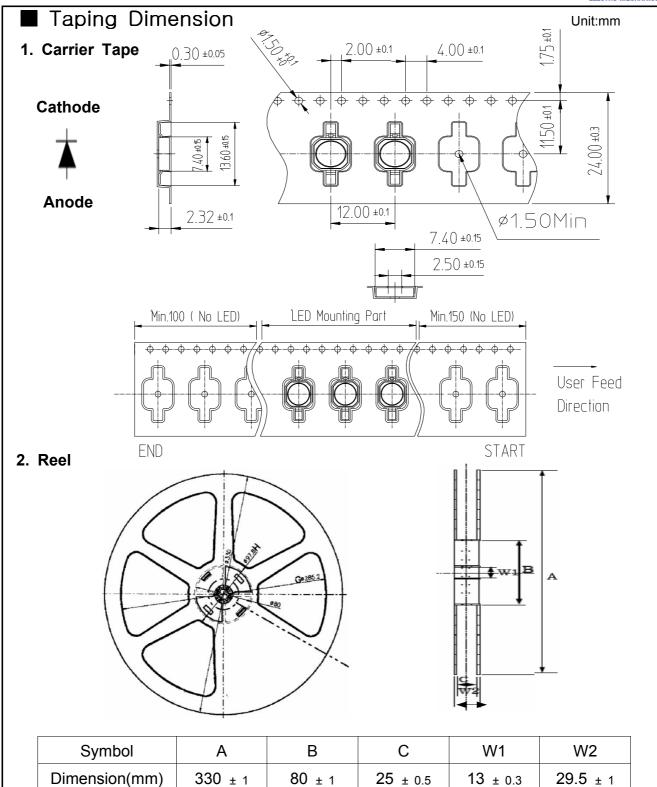
Reflow Frequency: 2 times max.



2) For Manual Soldering

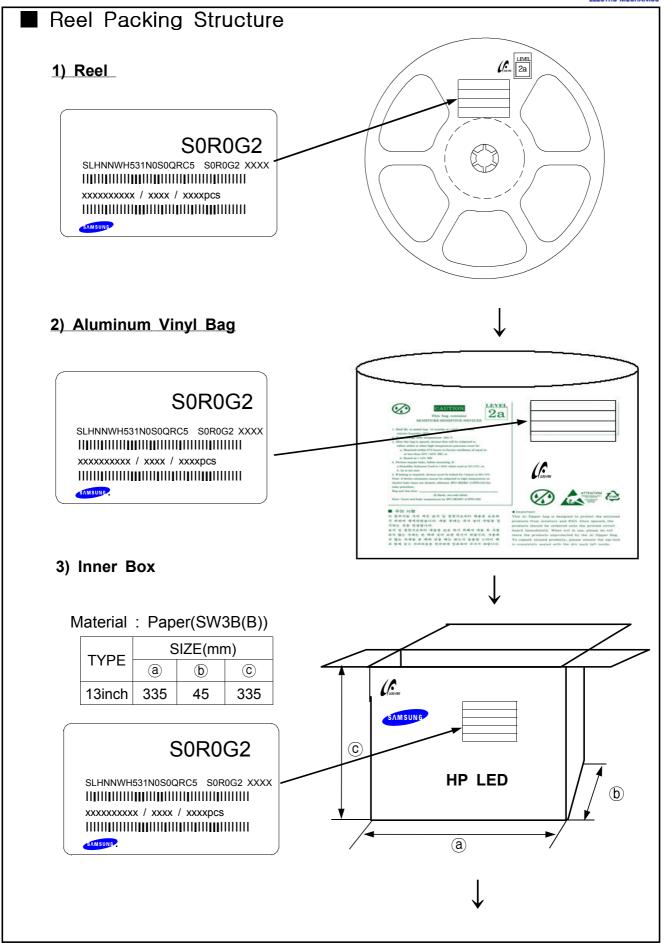
Not more than 5 seconds @MAX300℃, under soldering iron.





- (1) Quantity: 2,000 Pcs / 13" Reel.
- (2) Cumulative Tolerance: Cumulative Tolerance/10 pitches to be ±0.2mm
- (3) Adhesion Strength of Cover Tape: Adhesion strength to be 0.1-0.7N when the cover tape is turned off from the carrier tape at 10℃ angle to be the carrier tape.
- (4) Packaging: P/N, Manufacturing data Code No. and quantity to be indicated on a damp proof Package





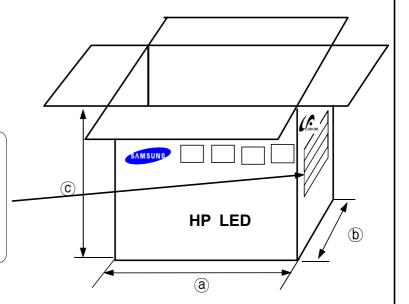


4) Carton Box

Material: Paper(SW3B(B))

TYPE	SIZE(mm)				
ITPE	<u>a</u>	b	\odot		
13inch	350	350	350		

S0R0G2



■ Label Structure

S0R0G2

(S0): VF Rank

(Q0): Chromaticity Coordinate Rank(CCT)

(G2): Luminous Flux

■ Lot Number

The Lot number is composed of the following characters

● ◎ ◇ ◆ □ ■ △ △ △ / I ▲ ▲ ▲ / 2000 PCS

• : Production Site (S:SEMCO, G:Gosin China)

○ : L (LED)

 \diamondsuit : Product State (A:Normality, B: Bulk, C:First Production, R:reproduction, S:Sample)

♦ : Year (Q:2006, R:2007, S:2008...)

 \square : Month (1 ~ 9, A, B)

 \blacksquare : Day (1 \sim 9, A, B \sim V)

 \triangle : SEMCo. Product number (1 \sim 999)

 \blacktriangle : Reel Number (1 \sim 999)





CAUTION

2a

This bag contains MOISTURE SENSITIVE DEVICES

- 1. Shelf life in sealed bag: 12 months at < 40 °C and < 90% relative humidity (RH)
- 2. Peak package body temperature: 240 °C
- 3. After this bag is opened, devices that will be subjected to reflow soldor or other high temperature processes must be:
 - a. Mounted within 672 hours at factory conditions of equal to or less than 30 $\!\!\!\!\!\!^{\circ}$ /60% RH, or
 - b. Stored at < 10% RH
- 4. Devices require bake, before mounting, if: a.Humidity Indicator Card is > 65% when read at 23 ± 5 °C, or b. 2a is not met.
- 5. If baking is required, devices must be baked for 1 hours at 60 ± 5 °C Note: if device containers cannot be subjected to high temperature or shorter bake times are desired, reference IPC/JEDEC J-STD-033 for bake procedure,

Bag seal due date:

(if blank, see code label)

Note: Level and body temperature by IPC/JEDEC J-STD-020

■ 주의 사항

이 알루미늄 지퍼 백은 습기 및 정전기로부터 제품을 보호하기 위하여 제작되었습니다. 개봉 후에는 즉시 솔더 작업을 실시하는 것을 권장합니다.

습기 및 정전기로부터 제품을 보호 하기 위해서 개봉 후 사용하지 않는 자재는 본 팩에 넣어 보관 하시기 바랍니다. 사용하지 않는 자재를 본 팩에 넣을 때는 반드시 동봉된 드라이 팩과 함께 넣고 지퍼부분을 완전하게 밀봉하여 주시기 바랍니다.

S0R0G2









■ Important

This Al Zipper bag is designed to protect the enclosed products from moisture and ESD. Once opened, the products should be soldered onto the printed circuit board immediately. When not in use, please do not leave the products unprotected by the Al Zipper Bag. To repack unused products., please ensure the zip-lock is completely sealed with the dry pack left inside.

Silical gel & Humidity Indicator Card in Aluminum Vinyl Bag







Precaution for Use

- 1) For over-current-proof function, customers are recommended to apply resistors to prevent sudden change of the current caused by slight shift of the voltage.
- 2) This device should not be used in any type of fluid such as water, oil, organic solvent, etc. When washing is required, IPA is recommended to use.
- 3) When the LEDs illuminate, operating current should be decided after considering the ambient maximum temperature.
- 4) LEDs must be stored in a clean environment.

 If the LEDs are to be stored for 3 months or more after being shipped from SEMCO, they should be packed by a sealed container with nitrogen gas injected. (Shelf life of sealed bags: 12 months, temp. 0~40°C, 20~70%RH)
- 5) After storage bag is open, device subjected to soldering, solder reflow, or other high temperature processes must be:
 - a. Mounted within 168 hours (7 days) at an assembly line with a condition of no more than 30°C/60%RH,
 - b. Stored at <10% RH.
- 6) Repack unused Products with anti-moisture packing, fold to close any opening and then store in a dry place.
- 7) Devices require baking before mounting, if humidity card reading is >60% at 23 ± 5 °C.
- 8) Devices must be baked for 24hours at 65±5°C, if baking is required.
- 9) The LEDs are sensitive to the static electricity and surge. It is recommended to use a wrist band or anti-electrostatic glove when handling the LEDs.

If voltage exceeding the absolute maximum rating is applied to LEDs, it may cause damage or even destruction to LED devices.

Damaged LEDs may show some unusual characteristics such as increase in leak current, lowered turn-on voltage, or abnormal lighting of LEDs at low current.



Page 1 of 3

■ Hazard Substance Analysis



Test Report No. F690501/LF-CTSAYA08-04155

SAMSUNG ELECTRO-MECHANICS CO., LTD.

314, Maetan3-dong Yeongtong-gu Suwon-city GYEONGGI-DO 442-373

The following merchandise was submitted and identified by the client as:

: LED **Product Name**

: AYA08-04155 SGS File No.

: February 04, 2008 Received Date

: February 05, 2008 **Test Performing Date**

: SGS Testing Korea tested the sample(s) selected by applicant with following results **Test Performed**

Test Results : For further details, please refer to following page(s)

: The sampling and testing was performed only for the part indicated in the photo without Comments

disassembly by the applicant's specific request.

SGS Testing Korea Co. Ltd.

Issued Date: February 11, 2008

Pluto Kim Monet Jeong

Billy Oh / Testing Person

Jeff Jang / Chemical Lab Mgr

F052 Version2





Test Report No. F690501/LF-CTSAYA08-04155 Issued Date: February 11, 2008 Page 2 of 3

: AYA08-04155.001 Sample No.

: LED Sample Description

Item No./Part No. : 7070 No Lens (Cool White)

Heavy Metals

Test Items	Unit	Test Method	MDL	Results
Cadmium (Cd)	mg/kg	US EPA 3050B(1996), US EPA 6010B(1996), ICP	0.5	N.D.
Lead (Pb)	mg/kg	US EPA 3050B(1996), US EPA 6010B(1996), ICP	5	N.D.
Mercury (Hg)	mg/kg	US EPA 3052(1996), US EPA 6010B(1996), ICP	2	N.D.
Hexavalent Chromium (Cr VI)	mg/kg	US EPA 3060A(1996), US EPA 7196A(1992), UV	1	N.D.

Flame Retardants-PBBs/PBDEs

Test Items	Unit	Test Method	MDL	Results
Monobromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Dibromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Tribromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Tetrabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Pentabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Hexabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Heptabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Octabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Nonabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Decabromobiphenyl	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Monobromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Dibromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Tribromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Tetrabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Pentabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Hexabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Heptabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Octabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Nonabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.
Decabromodiphenyl ether	mg/kg	US EPA 3540C, GC/MS	5	N.D.

NOTE: (1) N.D. = Not detected.(<MDL)

(2) mg/kg = ppm (3) MDL = Method Detection Limit

(4) - = No regulation (5) ** = Qualitative analysis (No Unit)

(6) Negative = Undetectable / Positive = Detectable





Test Report No. F690501/LF-CTSAYA08-04155

Issued Date: February 11, 2008 Page 3 of 3



*** End ***

- NOTE: (1) N.D. = Not detected.(<MDL)
 - (2) mg/kg = ppm
 - (3) MDL = Method Detection Limit
 - (4) = No regulation
 - (5) ** = Qualitative analysis (No Unit)
 - (6) Negative = Undetectable / Positive = Detectable

F052 Version2



Revision History (Model:SLHNNWH531N0S0QRC5)

Date Revision History	Author	
	Drawn	Approved
Initial Approval	K.T. Kim	S.J. Hong
		Revision History Drawn